





# **OTA TEST REPORT**

**Applicant** Espressif System (Shanghai) Co.,Ltd

**Product** ESP32-S3

Model ESP-ANT B

**Report No.** Y2102A0260-T3

**Issue Date** March 9, 2021

TA Technology (Shanghai) Co., Ltd. tested the above equipment in accordance with the requirements in **ANSI/IEEE Std 149-2008.** The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

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1. Test Laboratory

#### 1.1. Notes of the Test Report

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### 1.2. Test facility

A2LA (Certificate Number: 3857.01)

TA Technology (Shanghai) Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform measurement.

#### 1.3. Testing Location

Company: TA Technology (Shanghai) Co., Ltd.

Address: No.145, Jintang Rd, Tangzhen Industry Park, Pudong Shanghai, China

City: Shanghai

Post code: 201201

Country: P. R. China

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# 1.4. Laboratory Environment

Temperature	Min. =19℃,Max. = 25℃		
Relative humidity	Min. =40%, Max. =72%		
Shield effect	0.7-6GHz	> 100dB	
Ground resistance	<0.50	2	





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## 2. General Description of Equipment under Test

#### 2.1. Applicant and Manufacturer Information

Applicant Name	Espressif System (Shanghai) Co.,Ltd		
Applicant address	Suite 204 Block 2, 690 Bibo Road, Zhang Jiang Hi-Tech Park, Shanghai, China		
Manufacturer Name	Espressif System (Shanghai) Co.,Ltd		
Manufacturer address	Suite 204 Block 2, 690 Bibo Road, Zhang Jiang Hi-Tech Park, Shanghai, China		

#### 2.2. General information

EUT Description					
Product Name:	ESP32-S3				
Model	ESP-ANT B				
HW Version:	ESP32-S3 V1				
SW Version:	esp32s3_phy_20210225_no_sleep_and_ampdu				
Antenna Type:	PCB Antenna				
Antenna Manufacturer:	Espressif System (Shanghai) Co.,Ltd				
Test Frequency:	2402MHz ~ 2502MHz				

Note: The EUT is sent from the applicant to TA and the information of the EUT is declared by the applicant.

All indications of Pass/Fail in this report are opinions expressed by TA Technology (Shanghai) Co., Ltd. based on interpretations and/or observations of test results. Measurement Uncertainties were not taken into account and are published for informational purposes only.

Test lab. of the antenna gain and radiation pattern measurement: TA Technology (Shanghai) Co., Ltd.

#### 2.3. Test Date

The test is performed from February 25, 2021 to March 4, 2021.

#### 2.4. Receiving Date

The sample was received on February 25, 2021.



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### 2.5. Applied Standards

According to the specifications of the manufacturer, it must comply with the requirements of the following standards:

Test Method: ANSI/IEEE Std 149-2008





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#### 3. Test Conditions

### 3.1. Test Configuration

Great-Circle-Cut method is used to measure the antenna 3D GAIN of EUT in OTA qualified anechoic chamber. Equipment Under Test (EUT) geometry centre vertical projection at the centre of platform, the distance from EUT to measurement antenna is 5m.

#### 3.2. Test Measurement

#### Spherical coordinate system

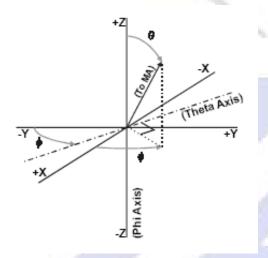
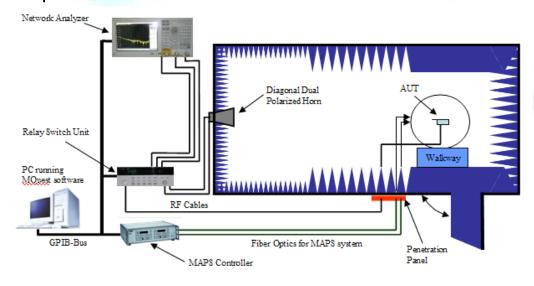


Figure 1 Test coordinate system

Note: Theta is from 0~180 degree. Phi is from 0~360. Rotate the EUT and record the Data, the step of rotation is 15 degree.

#### **Test Setup**





## 4. Test Results

## 4.1. Gain and Efficiency

Model	Test State	Frequency (MHz)	Efficiency (dB)	Efficiency (%)	Gain (dBi)	Directivity (dBi)	Note
		2402	-1.98	63.44	2.73	4.70	
		2407	-1.76	66.66	2.73	4.50	
		2412	-1.70	67.68	3.16	4.85	
		2417	-1.60	69.11	2.92	4.53	
		2422	-1.61	68.95	2.79	4.41	
		2427	-1.77	66.48	2.29	4.06	
1 1		2432	-1.83	65.54	2.54	4.37	
All the second	Free Space	2437	-1.73	67.21	2.46	4.19	
		2442	-1.77	66.46	2.56	4.34	
		2447	-1.79	66.25	2.69	4.48	
ESP-ANT B		2452	-1.75	66.81	2.95	4.70	15°
		2457	-1.76	66.73	2.96	4.71	
		2462	-1.68	67.91	2.99	4.67	
		2467	-1.95	63.90	3.17	5.11	W
		2472	-2.07	62.14	3.08	5.14	- 7
		2477	-1.87	65.00	3.18	5.05	
		2482	-1.94	63.96	3.26	5.20	
THE STATE OF		2487	-1.98	63.35	3.37	5.35	
		2492	-1.82	65.80	3.35	5.17	
1		2497	-1.72	67.34	3.17	4.88	1.0
		2502	-1.75	66.79	3.18	4.94	



# 5. Equipment List

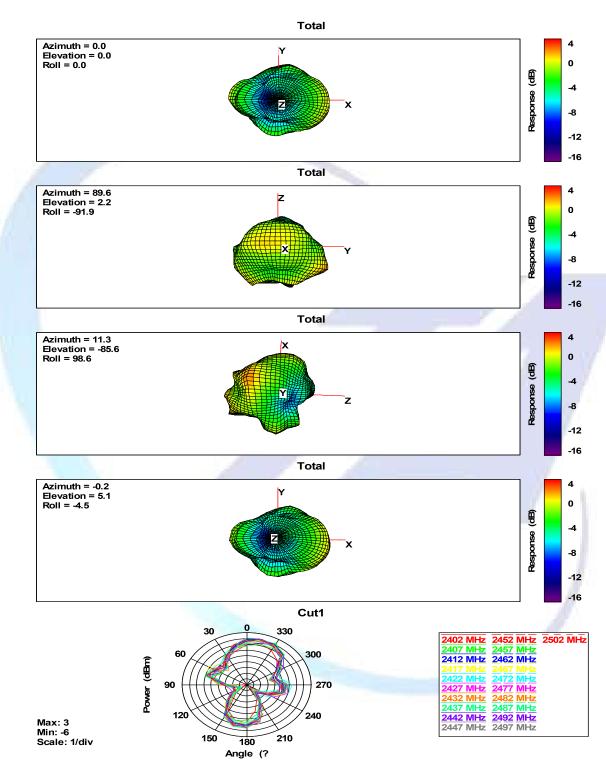
Type of Equipment	Manufacture	Model Number	S/N	Calibration Date	Expiration Time
Network Analyzer	Key sight	E5071B	MY42404014	2020-05-17	2021-05-16
Switch Control System	ETS	7006/7001	00059957/MY 42001152	N/A	N/A
Dual polarized horn antenna	ETS	3164-04	00062743	2020-04-14	2021-04-13
Software	ETS-lindgren	EMQ-100 Pattern Measurement software	1.09	N/A	N/A

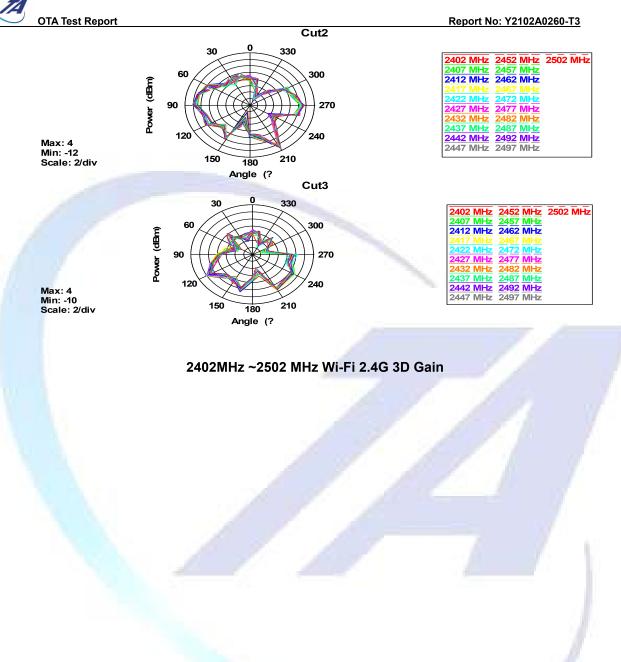




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### **ANNEX A 3-D Pattern Plots**



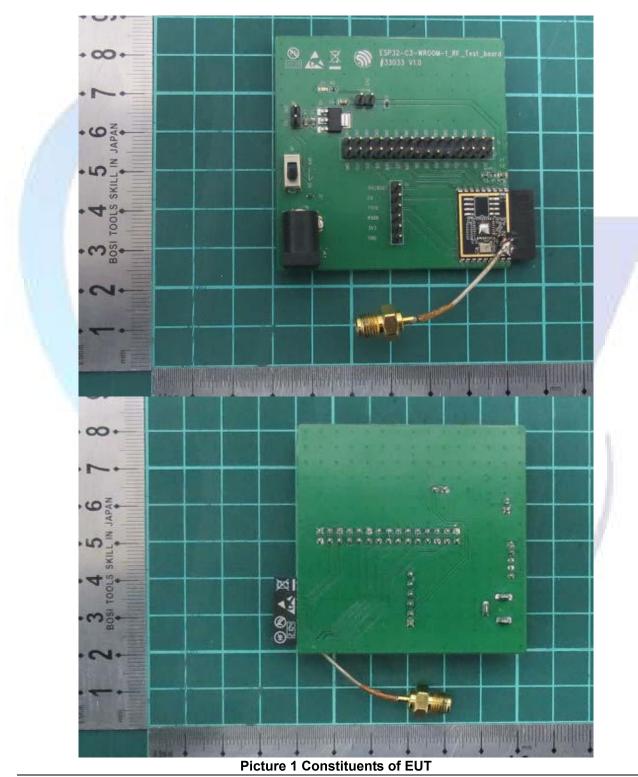




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# **ANNEX B: The EUT Appearance and Test Configuration**

## **B.1 EUT Appearance**



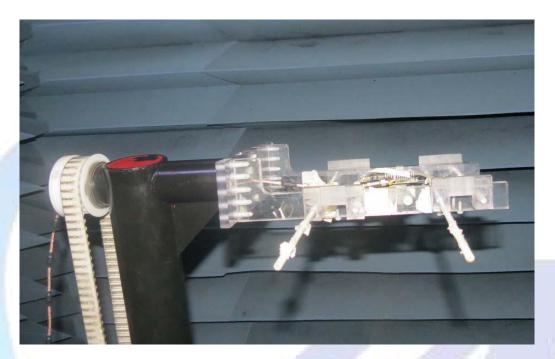
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# **B.2 Test Configuration**



**Picture 2 Test Setup** \*\*\*\*\*END OF REPORT \*\*\*\*\*